

# Search Notes



Application No.

10/693,102

Examiner

Jean F. Vollano

Applicant(s)

JAEHNE ET AL.

Art Unit

1621

## SEARCHED

Class	Subclass	Date	Examiner
514	706	4/28/04	JFV
514	712		
568	38		
568	39		
568	41		
568	42		
568	44		
568	48		
568	31		
568	52		
568	305		
564	340		
562	41		
562	405		
562	400		
560	30		
560	40		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
514	712	4/28/04	JFV

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
CAPLWS, BEILSTEIN see inside	4/28/2004	JFV
Newer search multiple copend app. <del>ODP</del> 10/01 on US 10/692/10	4/28/2004	JFV
also US 686 197 has similar subject matter in spec but by same inventor no ODP in this case.		